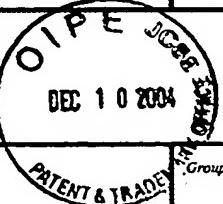


FORM PTO-1449 US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Attn. Docket No. 85975SHS Customer No. 01333		Serial No. 10/668,421	
<p>If AFTER the later date of the first Office Action or 3 months from filing, use only with <i>Request for Reconsideration</i> Certificate or Fee</p>					
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>		<i>Filing Date</i> 25 February 2003		<i>Group</i> 2883	
U.S. PATENT DOCUMENTS					
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
FOREIGN PATENT DOCUMENTS					
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)					
<i>edc</i>	'Resistivity Measurements on Buried Conductive Layers' by Robert A. Elder. EOS/ESD Symposium Proceedings, September 1990. pp. 251-254.				
EXAMINER <i>EinChen</i>	DATE CONSIDERED <i>7/28/05</i>				
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>					

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		Attn. Docket No. 85975SHS Customer No. 01333	Serial No. 10/668,421			
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		Filing Date 25 February 2003				
U.S. PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>ekc</i>	4,419,663	12-06-1983	Tadao Kohasi	340	783	03-07-1980
<i>ekc</i>	5,469,278	11-21-1995	Hiroshi Takahara et al.	359	51	11-18-1994

FOREIGN PATENT DOCUMENTS						
Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
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EXAMINER <i>ekc</i>	DATE CONSIDERED 7/28/05
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